


<b>Search Notes</b>  	<b>Application/Control No.</b>  10016765	<b>Applicant(s)/Patent Under Reexamination</b>  KAIZU ET AL.
	<b>Examiner</b>  Shang, Annan Q.	<b>Art Unit</b>  2424

SEARCHED			
Class	Subclass	Date	Examiner
Updated	See Previous	10/1/2006	CML
Updated	See Previous	4/30/2007	CML

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	10/1/2006	CML
EAST	4/30/2007	CML
Updated search	7/2/08	/A.S./
Updated search	1/26/09	/A.S./
Updated search	6/30/09	/A.S./
Updated search	12/16/09	/A.S./
Updated Search	04/06/10	/A.S./

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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